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Quantifying Reliability Statistics for Electrochemical Shock of Brittle Materials

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Quantifying Reliability Statistics for Electrochemical Shock of Brittle Materials

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Abstract

In brittle polycrystalline materials, anisotropic shape changes—such as those due to thermal expansion, composition changes, and piezoelectricity—can induce stresses severe enough to drive fracture. The stresses developed are microstructurally heterogeneous and develop in proportion to a generalized external stimulus rather than an applied load; as a consequence, traditional Weibull models do not capture the relevant scaling of failure probabilities with respect to applied stimulus or microstructural feature sizes. These limitations are surmounted by a stochastic method, called Finite Element plus Monte Carlo (FE+MC), which enables quantification of reliability statistics in brittle polycrystalline materials subjected to microstructurally heterogeneous stresses which may be driven by non-mechanical stimulii. A finite element analysis computes the stress distributions for a hypothetical defect-free virtual microstructure and a subsequent Monte Carlo analysis distributes flaws throughout the microstructure with sizes chosen from an experimental flaw size distribution. The FE+MC method is validated for uniaxial tensile loading, for which the expected Weibull distribution of failure probability is reproduced. As a demonstration of the utility of this method in a more complex stress state, we consider electrochemical shock of polycrystalline $Li_X CoO_2$ electrodes; the computed composition-dependent failure probabilities reproduce key features of experimental acoustic emission measurements not explained by previous modeling approaches.

Key words: fracture, microstructures, anisotropic material, polycrystalline material, probability and statistics

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